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Thunderbolt ∕ HS[™]

APT30GS60KR(G)

600V, 30A, $V_{CE(ON)} = 2.8V$ Typical

APT30GS60KR(G)

Thunderbolt[®] High Speed NPT IGBT

The Thunderbolt HS[™] series is based on thin wafer non-punch through (NPT) technology similar to the Thunderbolt[®] series, but trades higher V_{CE(ON)} for significantly lower turn-on energy E_{off}. The low switching losses enable operation at switching frequencies over 100kHz, approaching power MOSFET performance but lower cost.

An extremely tight parameter distribution combined with a positive $V_{CE(ON)}$ temperature coefficient make it easy to parallel Thunderbolts HS[™] IGBT's. Controlled slew rates result in very good noise and oscillation immunity and low EMI. The short circuit duration rating of 10µs make these IGBT's suitable for motor drive and inverter applications. Reliability is further enhanced by avalanche energy ruggedness.

Features

- Fast Switching with low EMI
- Very Low E_{OFF} for Maximum Efficiency
- Short circuit rated
- Low Gate Charge
- Tight parameter distribution
- Easy paralleling
- RoHS Compliant

Typical Applications

- ZVS Phase Shifted and other Full Bridge
- Half Bridge
- High Power PFC Boost
- Welding
- Induction heating
- High Frequency SMPS



Absolute Maximum Ratings						
Symbol	Parameter	Rating	Unit			
I _{C1}	Continuous Collector Current $T_C = @ 25^{\circ}C$	54				
I _{C2}	Continuous Collector Current $T_C = @ 100^{\circ}C$	30	A			
Г _{СМ}	Pulsed Collector Current ①	113				
V _{GE}	Gate-Emitter Voltage	±30V	V			
SSOA	Switching Safe Operating Area	113				
E _{AS}	Single Pulse Avalanche Energy ²	165	mJ			
t _{sc}	Short Circut Withstand Time ^③	10	μs			

Thermal and Mechanical Characteristics

Symbol	Parameter	Min	Тур	Max	Unit	
P _D	Total Power Dissipation $T_C = @ 25^{\circ}C$		-	250	W	
R _{0JC}	Junction to Case Thermal Resistance	-	-	0.50	°C/W	
R _{0CS}	Case to Sink Thermal Resistance, Flat Greased Surface	-	0.11	-		
T _J , T _{STG}	Operating and Storage Junction Temperature Range	-55	-	150	°C	
TL	Soldering Temperature for 10 Seconds (1.6mm from case)	-	-	300	Ŭ	
W _T	Package Weight	-	0.22	-	oz	
		-	5.9	-	g	
Torque	Mounting Torque, 6-32 M3 Screw	-	-	10	in·lbf	
		-	-	1.1	N∙m	

CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should be Followed.

Microsemi Website - http://www.microsemi.com

Static Characteristics

T_J = 25°C unless otherwise specified

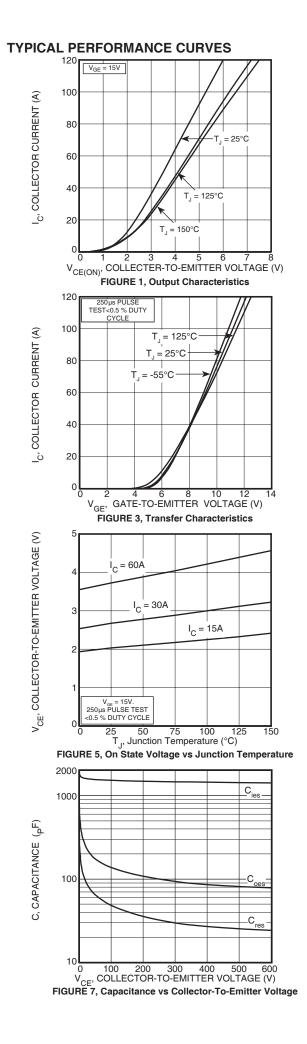
APT30GS60KR(G)

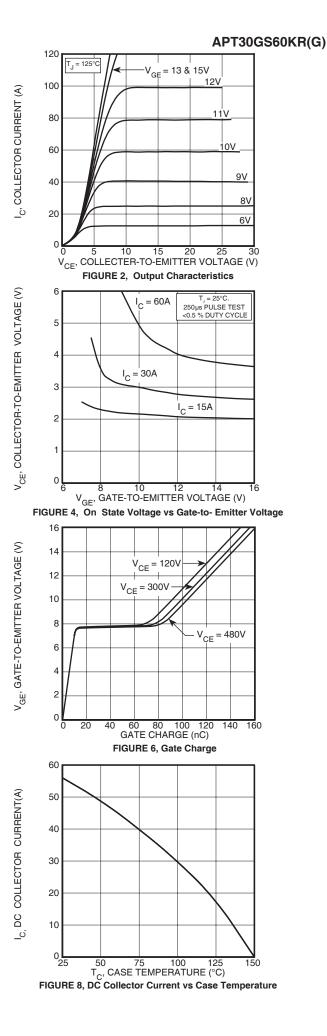
Symbol	Parameter	Test Conditions		Min	Тур	Max	Unit
V _{BR(CES)}	Collector-Emitter Breakdown Voltage	$V_{GE} = 0V, I_{C} = 250\mu A$		600	-	-	
V _{BR(ECS)}	Emitter-Collector Breakdown Voltage	$V_{GE} = 0V, I_C = 1A$		-	25	-	V
$\Delta V_{BR(CES)} / \Delta T_J$	Breakdown Voltage Temperature Coeff	Reference to 25°C, $I_{C} = 250 \mu A$		-	0.60	-	V/°C
V	Collector-Emitter On Voltage ⁽⁴⁾	GE	$T_J = 25^{\circ}C$	-	2.8	3.15	V
V _{CE(ON)}			T _J = 125°C	-	3.25	-	
V _{GE(th)}	Gate-Emitter Threshold Voltage	V – V I	- 1m A	3	4	5	
$\Delta V_{GE(th)} / \Delta T_J$	Threshold Voltage Temp Coeff	$V_{GE} = V_{CE}, I_C = 1mA$		-	6.7	-	mV/°C
I _{CES}	Zero Gate Voltage Collector Current	UE CE CE	$T_J = 25^{\circ}C$	-	-	50	
			T _J = 125°C	-	-	1000	μA
I _{GES}	Gate-Emitter Leakage Current	$V_{GE} = \pm 20V$		-	-	±100	nA

Dynamic Characteristics

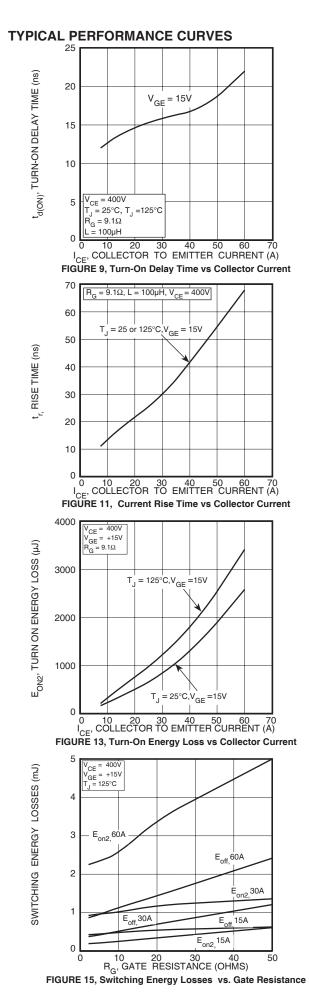
 $T_J = 25^{\circ}C$ unless otherwise specified

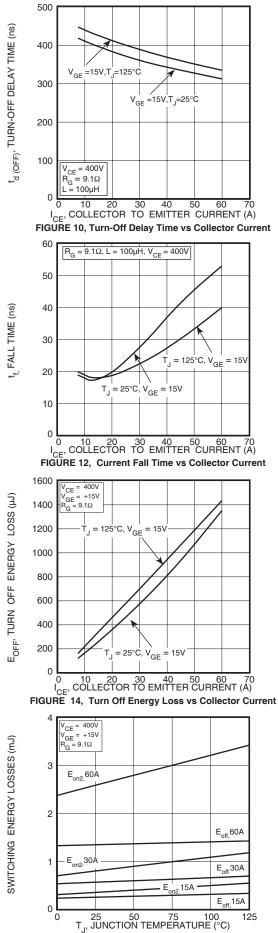
Symbols	Parameter	Test Conditions	Min	Тур	Max	Unit
9 _{fs}	Forward Transconductance	$V_{CE} = 50V, I_{C} = 30A$	-	18	-	S
C _{ies}	Input Capacitance		-	1600	-	pF
C _{oes}	Output Capacitance	$V_{GE} = 0V, V_{CE} = 25V$ f = 1MHz	-	140	-	
C _{res}	Reverse Transfer Capacitance		-	90	-	
C _{o(cr)}	Reverse Transfer Capacitance Charge Related ⁽⁵⁾	V _{GE} = 0V	-	130	-	
C _{o(er)}	Reverse Transfer Capacitance Current Related ⁶	$V_{GE} = 0V$ $V_{CE} = 0 \text{ to } 400V$		95		
Qg	Total Gate Charge		-	145	-	nC
Q_{ge}	Gate-Emitter Charge	$V_{GE} = 0 \text{ to } 15V$ $I_C = 30A, V_{CE} = 300V$	-	12	-	
G _{gc}	Gate-Collector Charge	$-1_{\rm C} = 500$, $V_{\rm CE} = 500$ V	-	65	-	
t _{d(on)}	Turn-On Delay Time		-	16	-	ns
t _r	Rise Time	Inductive Switching IGBT and	-	29	-	
t _{d(off)}	Turn-Off Delay Time	Diode:	-	360	-	
t _f	Fall Time	T _J = 25°C, V _{CC} = 400V,	-	27	-	
E _{on1}	Turn-On Switching Energy [®]	$I_c = 30A$	-	TBD	-	mJ
E _{on2}	Turn-On Switching Energy ⁽⁹⁾	$I_{c} = 30A$ $R_{G} = 9.1\Omega^{(7)}, V_{GG} = 15V$	-	800	-	
E _{off}	Turn-Off Switching Energy 10		-	570	-	
t _{d(on)}	Turn-On Delay Time		-	16	-	
t _r	Rise Time	Inductive Switching IGBT and Diode:	-	29	-	- ns
t _{d(off)}	Turn-Off Delay Time		-	390	-	
t _f	Fall Time	$T_{\rm J} = 125^{\circ}C, V_{\rm CC} = 400V,$	-	22	-	
E _{on1}	Turn-On Switching Energy [®]	$I_{c} = 30A$ $R_{G} = 9.1\Omega^{7}, V_{GG} = 15V$	-	TBD	-	
E _{on2}	Turn-On Switching Energy ⁽⁹⁾	$\Pi_{G} = 9.1 M \odot, V_{GG} = 15V$	-	1185	-	mJ
E _{off}	Turn-Off Switching Energy 10		-	695	-	





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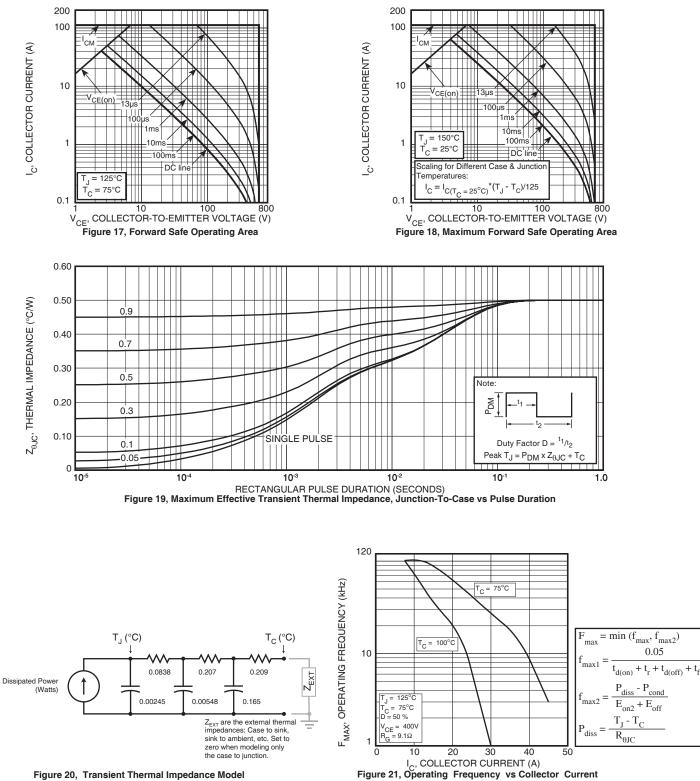




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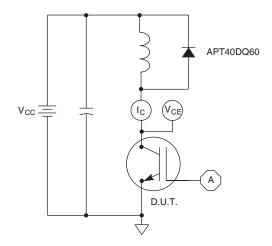
FIGURE 16, Switching Energy Losses vs Junction Temperature

TYPICAL PERFORMANCE CURVES





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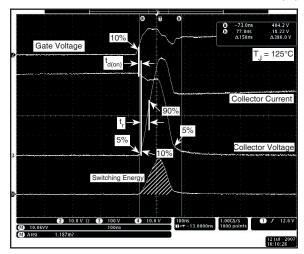


Figure 23, Turn-on Switching Waveforms and Definitions

Figure 22, Inductive Switching Test Circuit

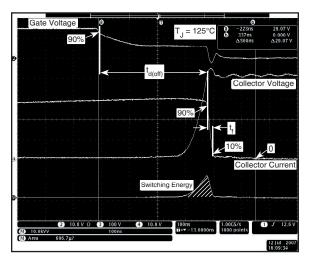
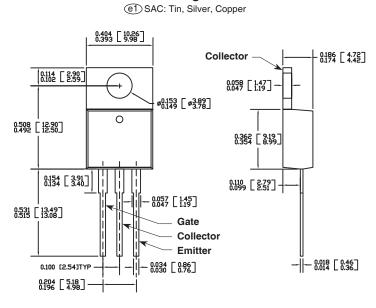


Figure 24, Turn-off Switching Waveforms and Definitions

FOOT NOTE:

- (1) Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.
- (2) Starting at $T_J = 25^{\circ}C$, $L = 224\mu$ H, $R_G = 25\Omega$, $I_C = 30A$
- 3 Short circuit time: V_{GE} = 15V, V_{CC} \leq 600V, T_J \leq 150°C
- (4) Pulse test: Pulse width < 380µs, duty cycle < 2%
- (5) $C_{o(cr)}$ is defined as a fixed capacitance with the same stored charge as C_{oes} with $V_{CE} = 67\%$ of $V_{(BR)CES}$.
- (6) $C_{o(er)}$ is defined as a fixed capacitance with the same stored energy as C_{oes} with $V_{CE} = 67\%$ of $V_{(BR)CES}$. To calculate $C_{o(er)}$ for any value of V_{CE} less than $V_{(BR)CES}$, use this equation: $C_{o(er)} = -1.40E-7/V_{DS}^{2} + 1.47E-8/V_{DS} + 5.95E-11$. \bigcirc R_{G} is external gate resistance, not including internal gate resistance or gate driver impedance (MIC4452).
- (8) E_{on1} is the inductive turn-on energy of the IGBT only, without the effect of a commutating diode reverse recovery current adding to the IGBT turn-on switching loss. It is measured by clamping the inductance with a Silicon Carbide Schottky diode.
- (9) E_{on2} is the inductive turn-on energy that includes a commutating diode reverse recovery current in the IGBT turn-on energy.
- (1) Eoff is the clamped inductive turn-off energy measured in accordance with JEDEC standard JESD24-1.

Microsemi reserves the right to change, without notice, the specifications and information contained herein.



TO-220 K Package Outline

Dimensions in Inches and (Millimeters)